

Dual N-Channel Enhancement Mode Power MOSFET

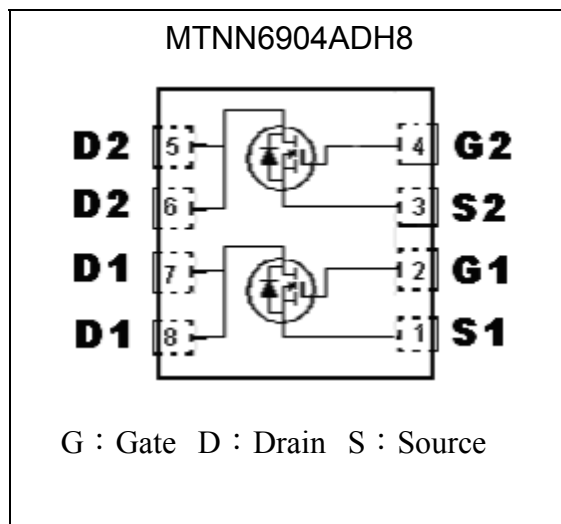
MTNN6904ADH8

Features

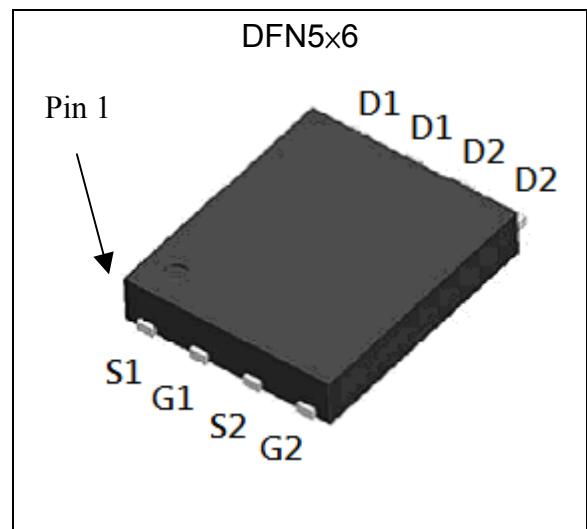
- Low On Resistance
- Simple Drive Requirement
- Low Gate Charge
- Fast Switching Characteristic
- Pb-free lead plating and Halogen-free package

	Tr 1	Tr 2
BV_{DSS}	40V	40V
I_D@V_{GS}=10V, T_C=25°C	35A	53A
I_D@V_{GS}=10V, T_C=100°C	22A	33.5A
I_D@V_{GS}=10V, T_A=25°C	11A	14.5A
I_D@V_{GS}=10V, T_A=70°C	8.8A	11.6A
R_{DS(ON)}@V_{GS}=10V, I_D=12A(typ)	10.7mΩ	6.2mΩ
R_{DS(ON)}@V_{GS}=4.5V, I_D=10A(typ)	14.0mΩ	8.4mΩ

Equivalent Circuit

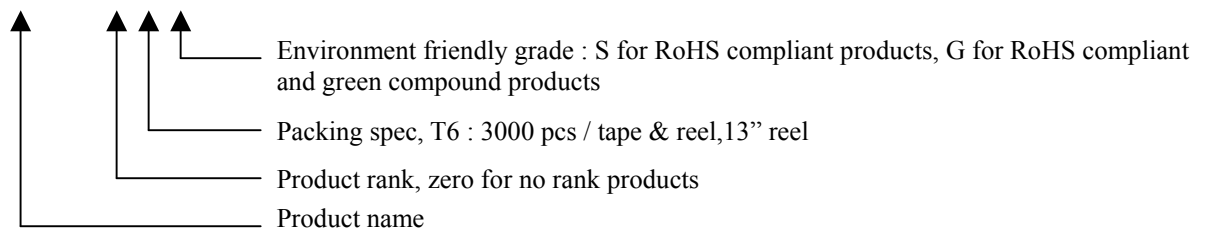


Outline



Ordering Information

Device	Package	Shipping
MTNN6904ADH8-0-T6-G	DFN 5 x6 (Pb-free lead plating and halogen-free package)	3000 pcs / tape & reel



**Absolute Maximum Ratings** ($T_C=25^{\circ}\text{C}$, unless otherwise noted)

Parameter		Symbol	Limits		Unit
			Tr 1	Tr 2	
Drain-Source Voltage		V _{DS}	40	40	V
Gate-Source Voltage		V _{GS}	±20	±20	
Continuous Drain Current @T _C =25°C, V _{GS} =10V (Note 1)		I _D	35	53	A
Continuous Drain Current @T _C =100°C, V _{GS} =10V (Note 1)			22	33.5	
Continuous Drain Current @T _A =25°C, V _{GS} =10V (Note 2)		I _{DSM}	11	14.5	
Continuous Drain Current @T _A =70°C, V _{GS} =10V (Note 2)			8.8	11.6	
Pulsed Drain Current (Note 3)		I _{DM}	140	212	
Avalanche Current @L=0.1mH (Note 3)		I _{AS}	18	40	mJ
Single Pulse Avalanche Energy (Note 4)		E _{AS}	32	72	
Repetitive Avalanche Energy (Note 3)		E _{AR}	3.1	4.2	
Power Dissipation	T _C =25°C (Note 1)	P _D	31	42	W
	T _C =100°C (Note 1)		12.4	16.8	
	T _A =25°C (Note 2)	P _D SM	3.1	3.1	
	T _A =70°C (Note 2)		2	2	
Operating Junction and Storage Temperature		T _j , T _{stg}	-55~+150		°C

*Drain current limited by maximum junction temperature

Thermal Data

Parameter	Symbol	Value		Unit
		Tr 1	Tr 2	
Thermal Resistance, Junction-to-case, max	$R_{\theta JC}$	4	3	$^{\circ}\text{C/W}$
Thermal Resistance, Junction-to-ambient, max (Note 5)	$R_{\theta JA}$	40	40	
Thermal Resistance, Junction-to-ambient, max (Note 6)		70	70	

- Note : 1. The power dissipation P_D is based on $T_{J(MAX)}=150^{\circ}\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
2. The value of $R_{\theta JA}$ is measured with the device mounted on 1 in²FR-4 board with 2 oz. copper, in a still air environment with $T_A=25^{\circ}\text{C}$, $t \leq 10\text{s}$. The value in any given application depends on the user's specific board design. The power dissipation P_{DSM} is based on $R_{\theta JA}$ and the maximum allowed junction temperature of 150°C .
3. Ratings are based on low frequency and low duty cycles to keep initial $T_J=25^{\circ}\text{C}$.
4. Tr 1 : $L=1\text{mH}$, $I_{AS}=8\text{A}$, $V_{GS}=10\text{V}$, $V_{DD}=15\text{V}$. Tr 2 : $L=1\text{mH}$, $I_{AS}=12\text{A}$, $V_{GS}=10\text{V}$, $V_{DD}=15\text{V}$.
5. When mounted on 1 in² copper pad of FR-4 board, $t \leq 10\text{s}$.
6. When mounted on 1 in² copper pad of FR-4 board, steady state.

**Tr 1 Characteristics (Tj=25°C, unless otherwise specified)**

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	40	-	-	V	V _{GS} =0V, I _D =250μA
ΔBV _{DSS} /ΔT _j	-	0.03	-	V/°C	Reference to 25°C, I _D =250μA
V _{GS(th)}	1.0	-	2.5	V	V _{DS} = V _{GS} , I _D =250μA
*G _{FS}	-	10.5	-	S	V _{DS} =10V, I _D =10A
I _{GSS}	-	-	±100	nA	V _{GS} =±20V
I _{DSS}	-	-	1	μA	V _{DS} =32V, V _{GS} =0V
	-	-	25		V _{DS} =32V, V _{GS} =0V, T _j =85°C
*R _{DS(ON)}	-	10.7	14	mΩ	V _{GS} =10V, I _D =12A
	-	14.0	20		V _{GS} =4.5V, I _D =10A
Dynamic					
*Q _g	-	7.2	10.8	nC	V _{DS} =20V, I _D =6A, V _{GS} =4.5V
*Q _{gs}	-	2.3	-		
*Q _{gd}	-	2.8	-		
*t _{d(ON)}	-	7.8	11.7	ns	V _{DS} =20V, I _D =1A, V _{GS} =10V, R _G =3.3Ω
*t _r	-	16.2	24.3		
*t _{d(OFF)}	-	36.6	54.9		
*t _f	-	8	12		
C _{iss}	-	682	1023	pF	V _{GS} =0V, V _{DS} =15V, f=1MHz
C _{oss}	-	119	150		
C _{rss}	-	59	89		
R _g	-	3.5	-	Ω	f=1MHz
Source-Drain Diode					
*I _S	-	-	35	A	
*I _{SM}	-	-	140		
*V _{SD}	-	0.73	1.1	V	I _S =1A, V _{GS} =0V
*t _{rr}	-	9.1	-	ns	V _{GS} =0V, I _F =10A, dI _F /dt=100A/μs
*Q _{rr}	-	3.9	-	nC	

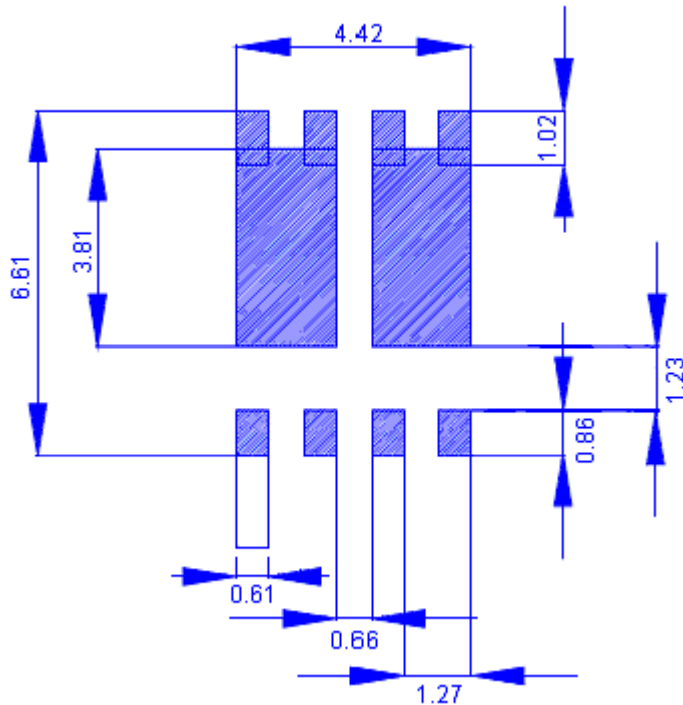
*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

**Tr 2 Characteristics (Tj=25°C, unless otherwise specified)**

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	40	-	-	V	V _{GS} =0V, I _D =250μA
ΔBV _{DSS} /ΔT _j	-	0.03	-	V/°C	Reference to 25°C, I _D =250μA
V _{GS(th)}	1.0	-	2.5	V	V _{DS} = V _{GS} , I _D =250μA
*G _{FS}	-	15.5	-	S	V _{DS} =10V, I _D =10A
I _{GSS}	-	-	±100	nA	V _{GS} =±20V
I _{DSS}	-	-	1	μA	V _{DS} =32V, V _{GS} =0V
	-	-	25		V _{DS} =32V, V _{GS} =0V, T _j =85°C
*R _{DS(ON)}	-	6.2	8	mΩ	V _{GS} =10V, I _D =12A
	-	8.4	11		V _{GS} =4.5V, I _D =10A
Dynamic					
*Q _g	-	17.4	26.1	nC	V _{DS} =20V, I _D =8A, V _{GS} =4.5V
*Q _{gs}	-	4.5	-		
*Q _{gd}	-	7.9	-		
*t _{d(ON)}	-	13.4	20.1	ns	V _{DS} =20V, I _D =1A, V _{GS} =10V, R _G =3.3Ω
*t _r	-	19.8	29.7		
*t _{d(OFF)}	-	53.4	80.1		
*t _f	-	12.4	18.6		
C _{iss}	-	1448	2172	pF	V _{GS} =0V, V _{DS} =15V, f=1MHz
C _{oss}	-	202	303		
C _{rss}	-	144	216		
R _g	-	2.9	-	Ω	f=1MHz
Source-Drain Diode					
*I _S	-	-	53	A	
*I _{SM}	-	-	212		
*V _{SD}	-	0.71	1.1	V	I _S =1A, V _{GS} =0V
*t _{rr}	-	12.6	-	ns	V _{GS} =0V, I _F =12A, dI _F /dt=100A/μs
*Q _{rr}	-	6.5	-	nC	

*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

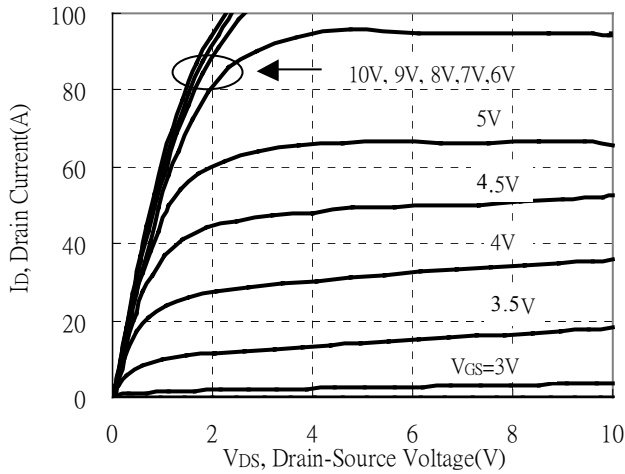
Recommended Soldering Footprint



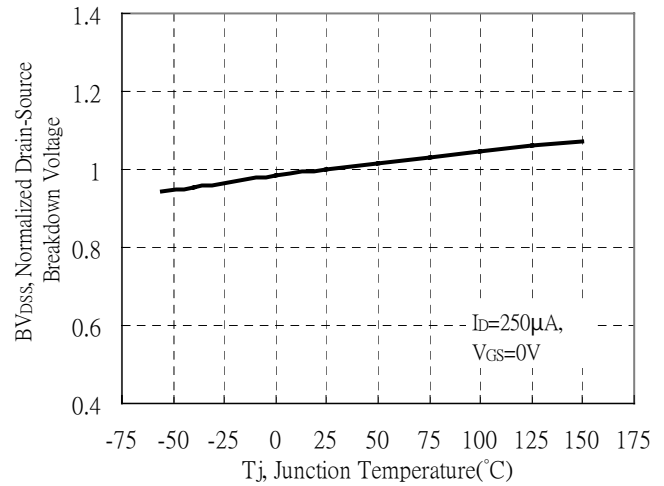
unit : mm

Tr 1 Typical Characteristics

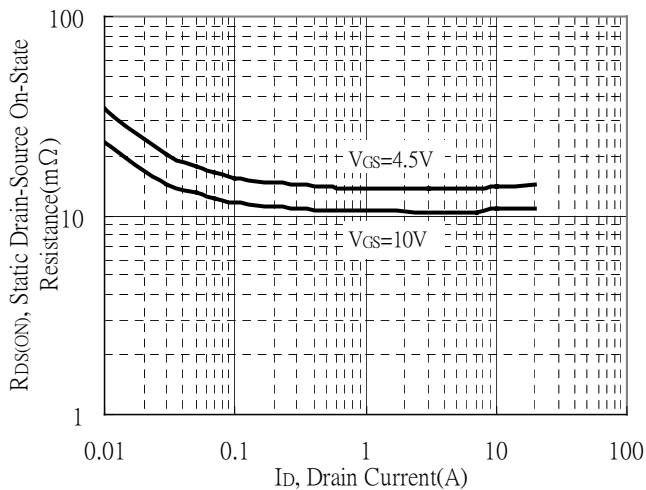
Typical Output Characteristics



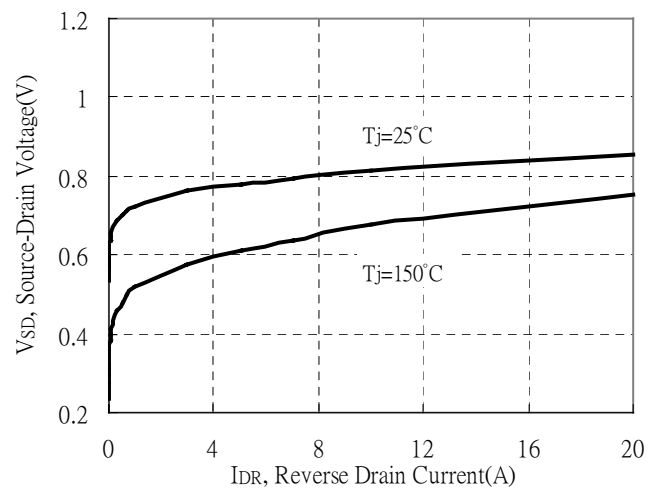
Brekdown Voltage vs Ambient Temperature



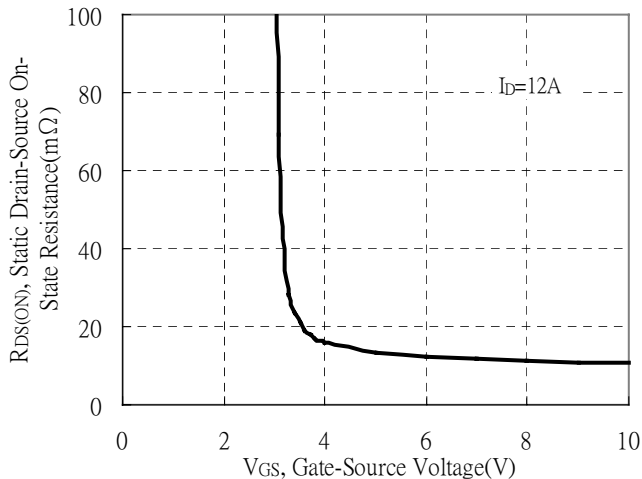
Static Drain-Source On-State resistance vs Drain Current



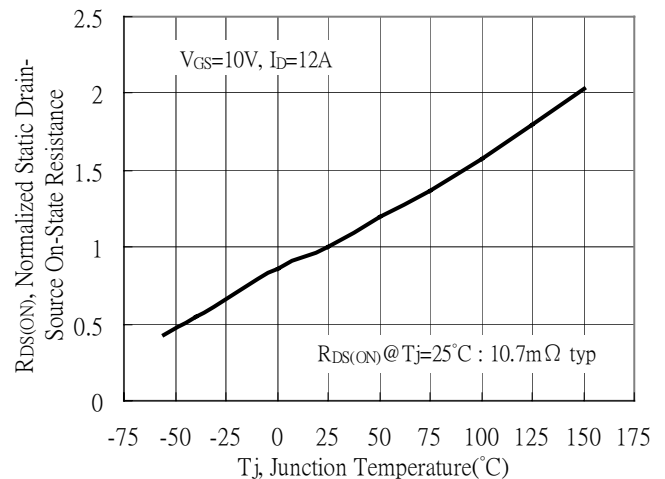
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

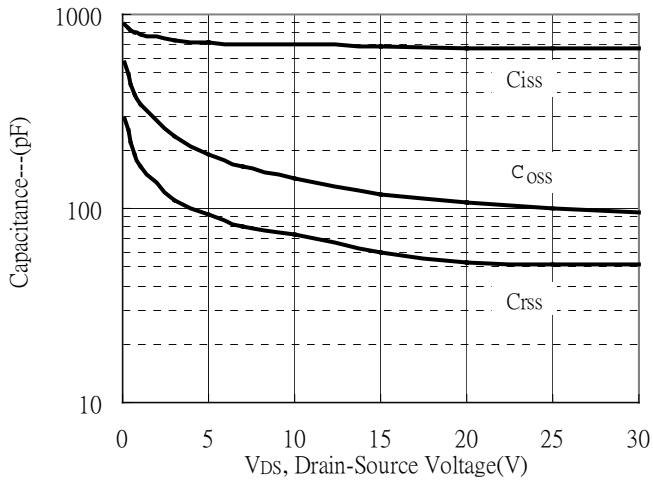


Drain-Source On-State Resistance vs Junction Temperature

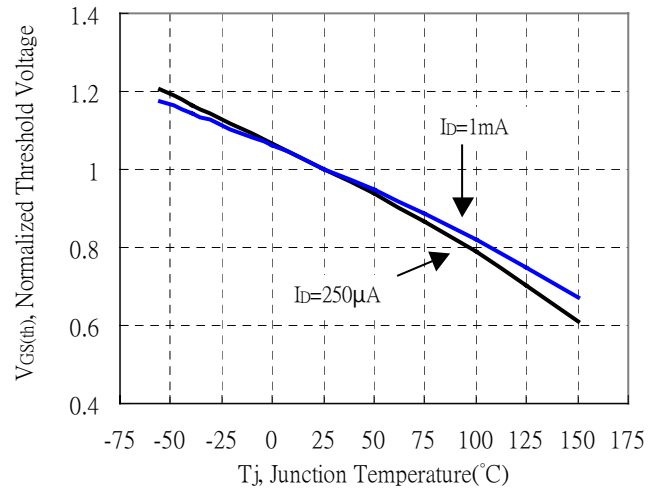


Tr 1 Typical Characteristics(Cont.)

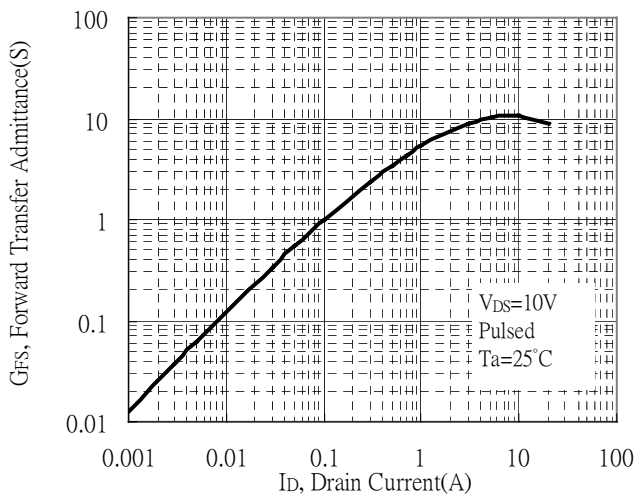
Capacitance vs Drain-to-Source Voltage



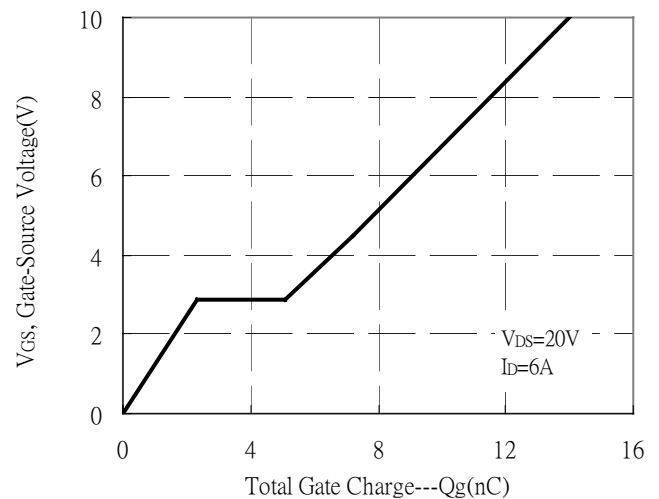
Normalized Threshold Voltage vs Junction Temperature



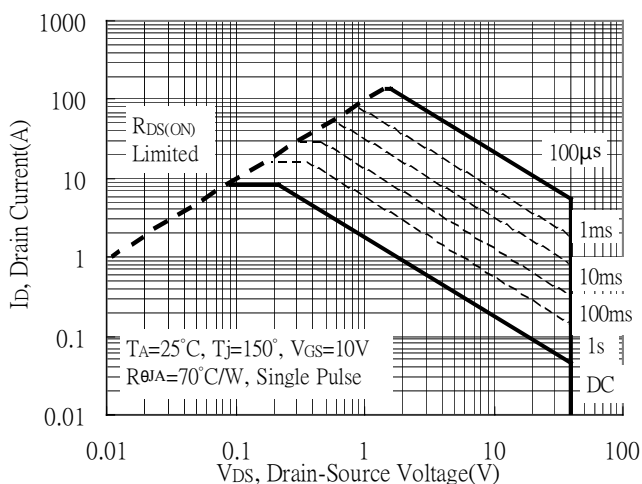
Forward Transfer Admittance vs Drain Current



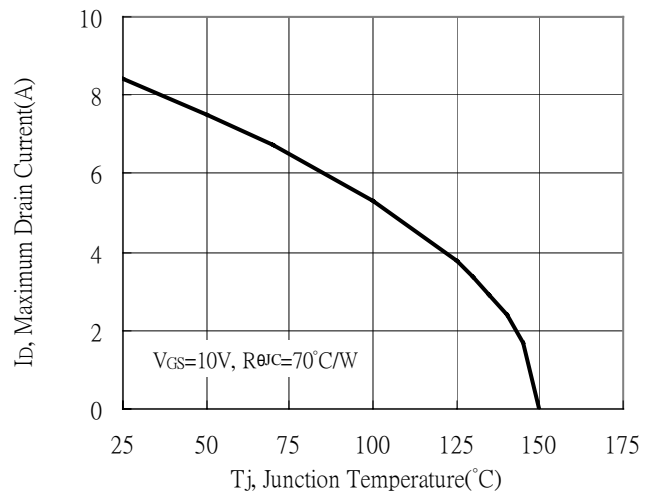
Gate Charge Characteristics



Maximum Safe Operating Area

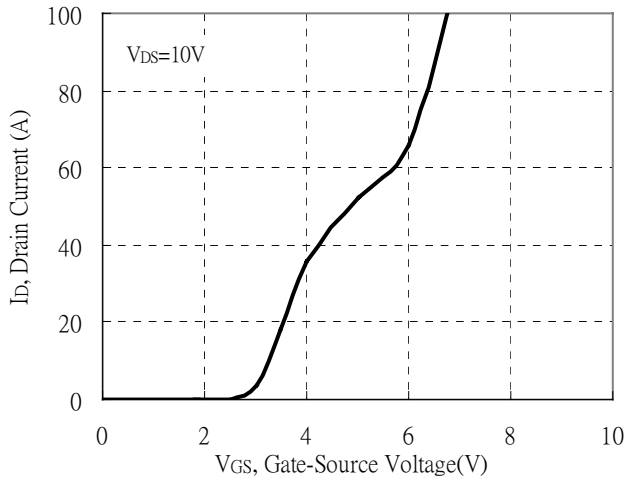


Maximum Drain Current vs Junction Temperature

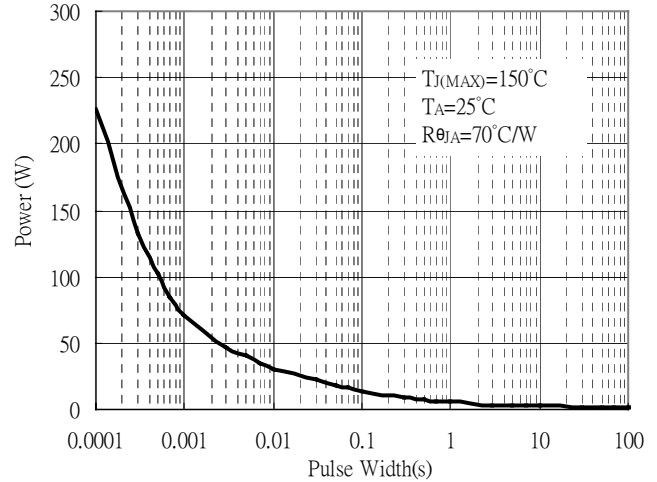


Tr 1 Typical Characteristics(Cont.)

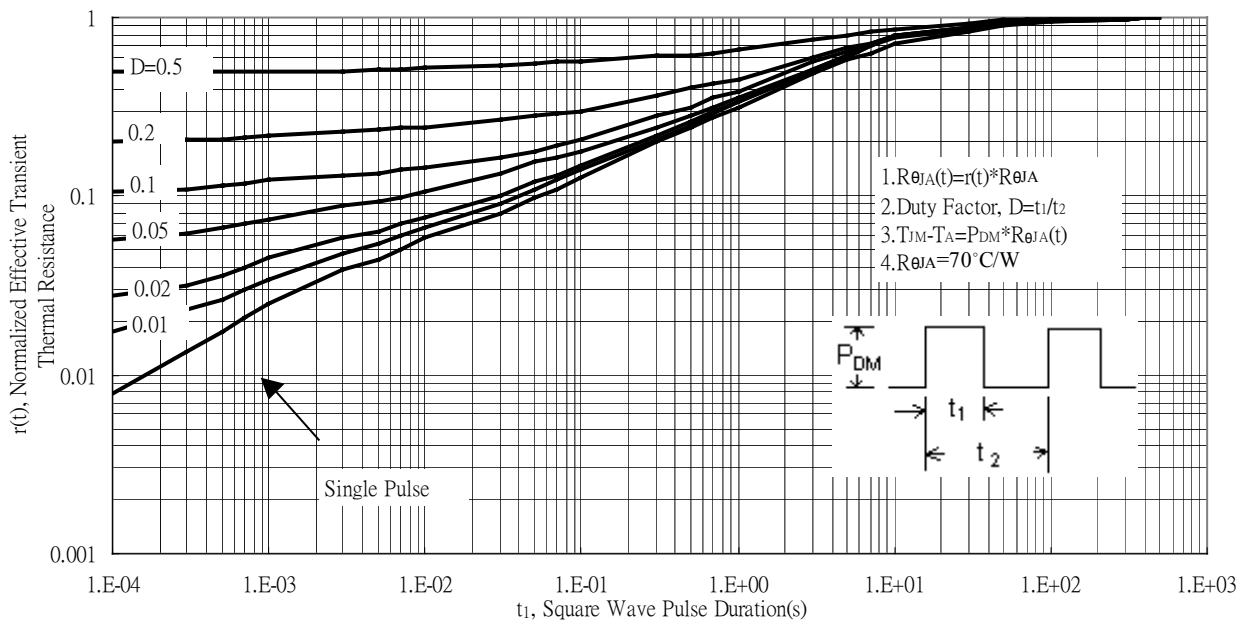
Typical Transfer Characteristics



Single Pulse Maximum Power Dissipation

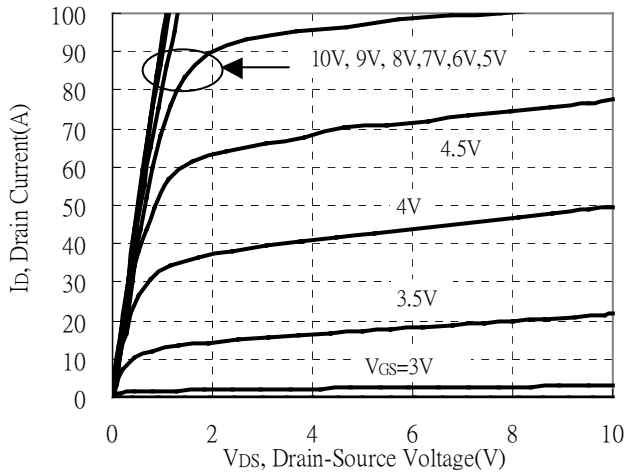


Transient Thermal Response Curves

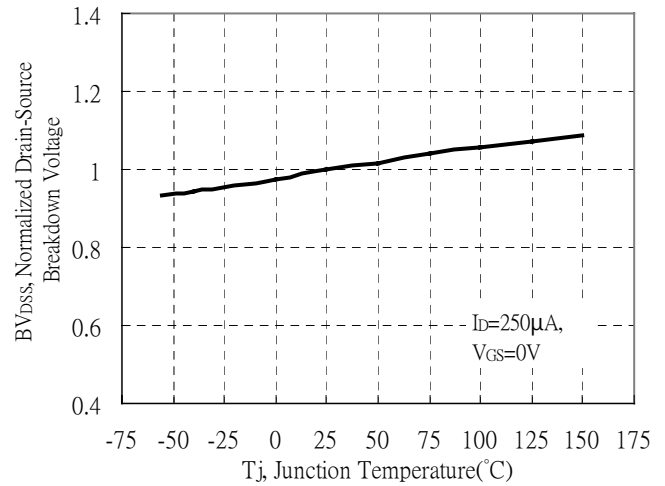


Tr 2 Typical Characteristics

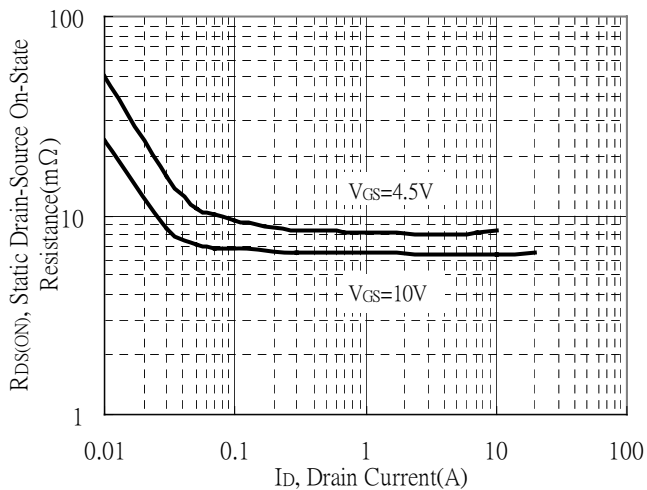
Typical Output Characteristics



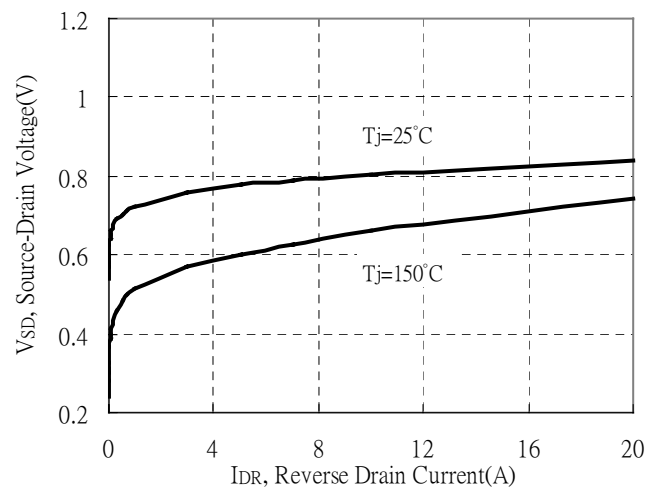
Brekdown Voltage vs Ambient Temperature



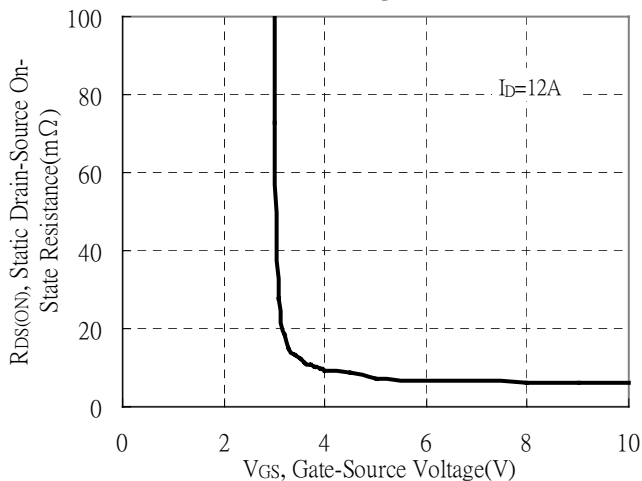
Static Drain-Source On-State resistance vs Drain Current



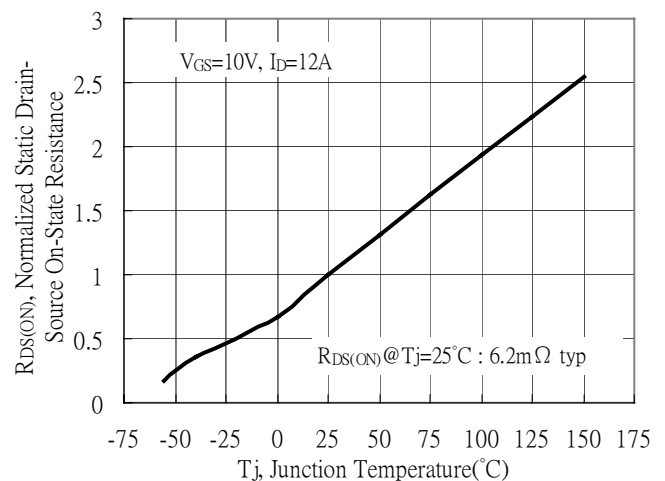
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

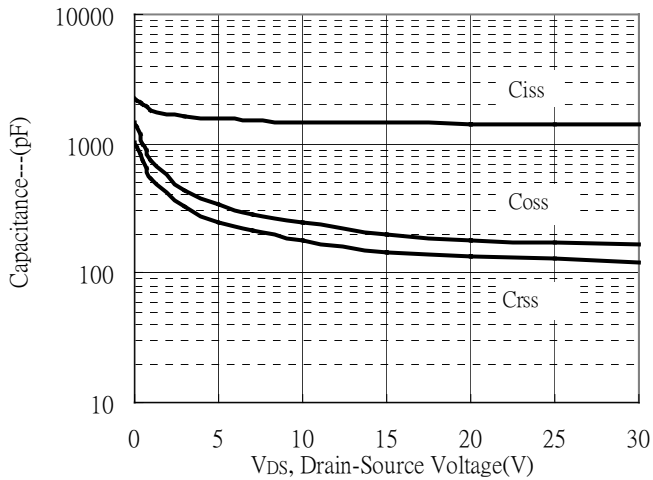


Drain-Source On-State Resistance vs Junction Temperature

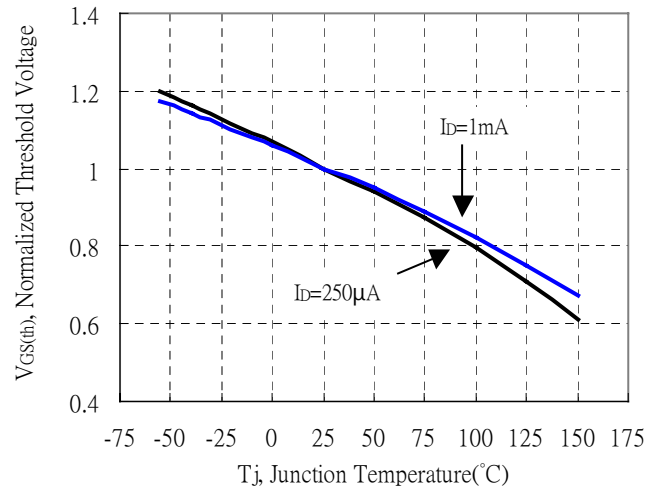


Tr 2 Typical Characteristics(Cont.)

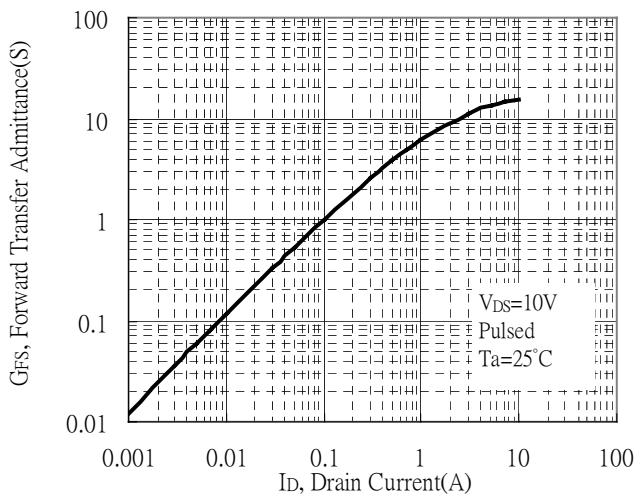
Capacitance vs Drain-to-Source Voltage



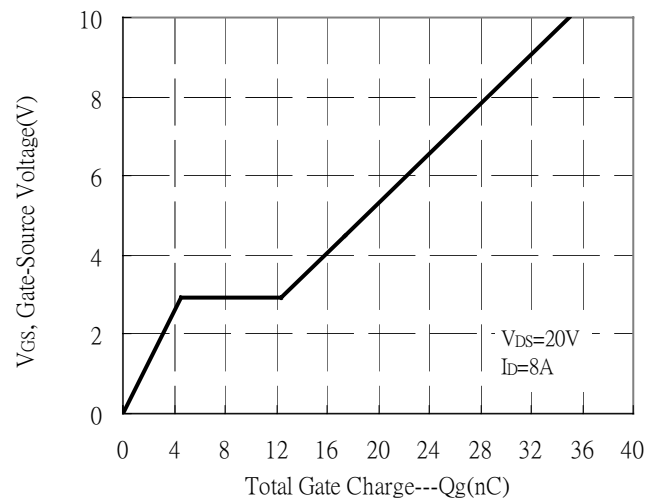
Normalized Threshold Voltage vs Junction Temperature



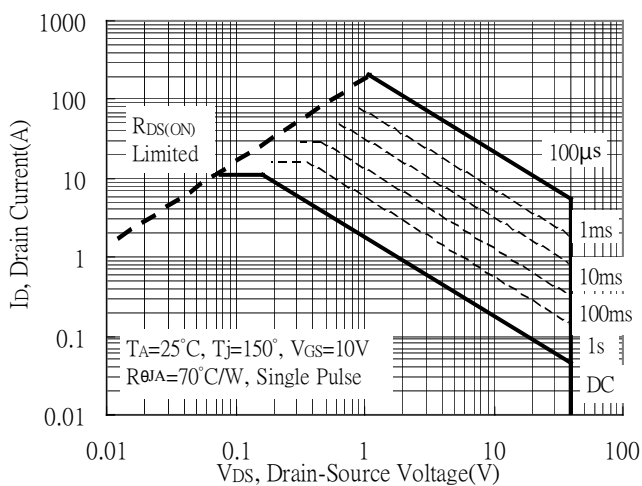
Forward Transfer Admittance vs Drain Current



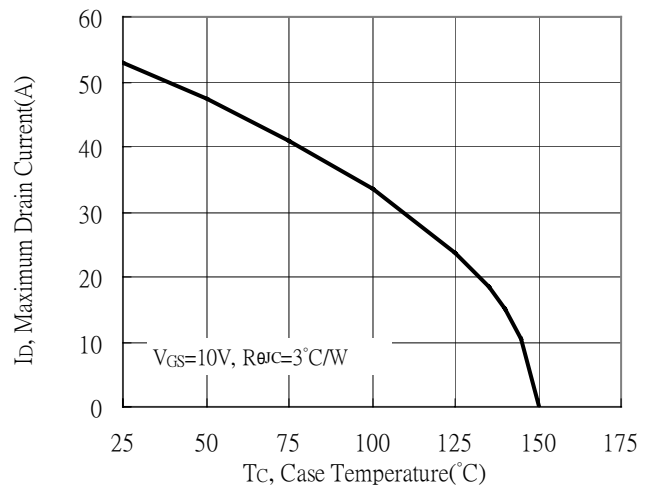
Gate Charge Characteristics



Maximum Safe Operating Area

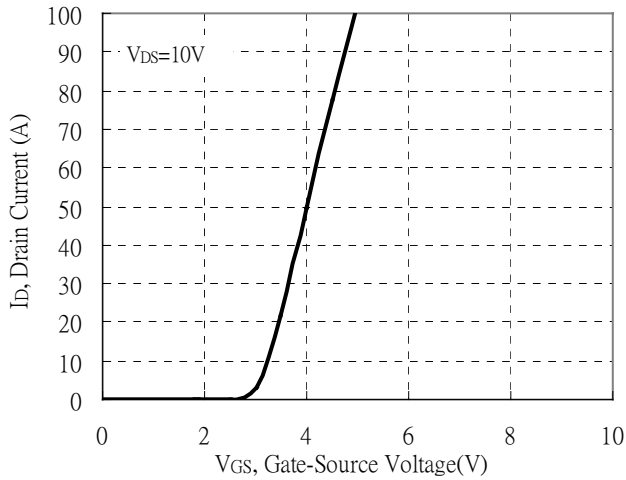


Maximum Drain Current vs Case Temperature

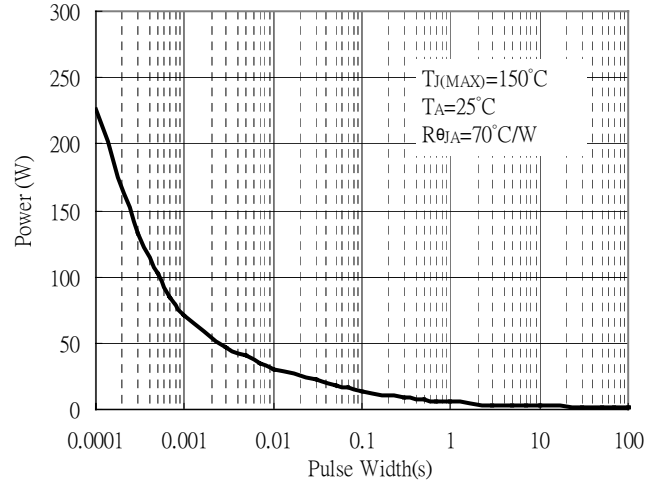


Tr 2 Typical Characteristics(Cont.)

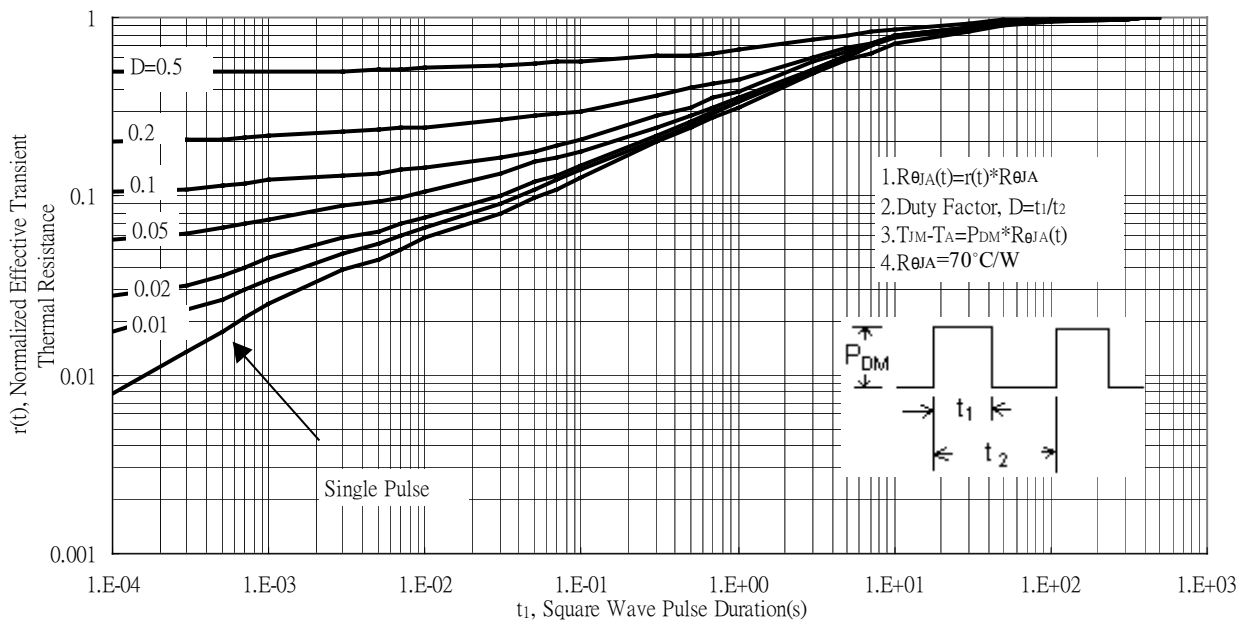
Typical Transfer Characteristics



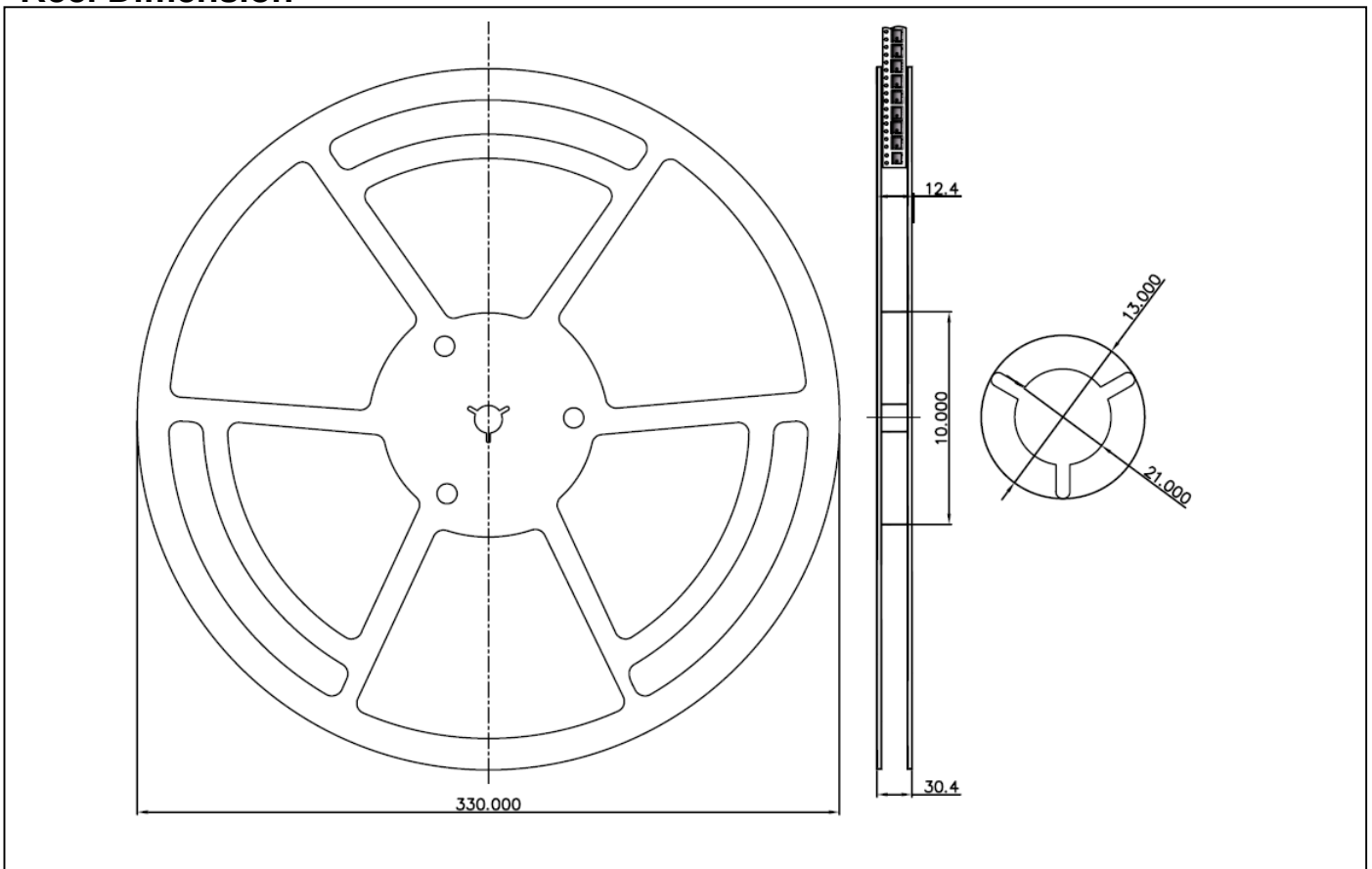
Single Pulse Maximum Power Dissipation



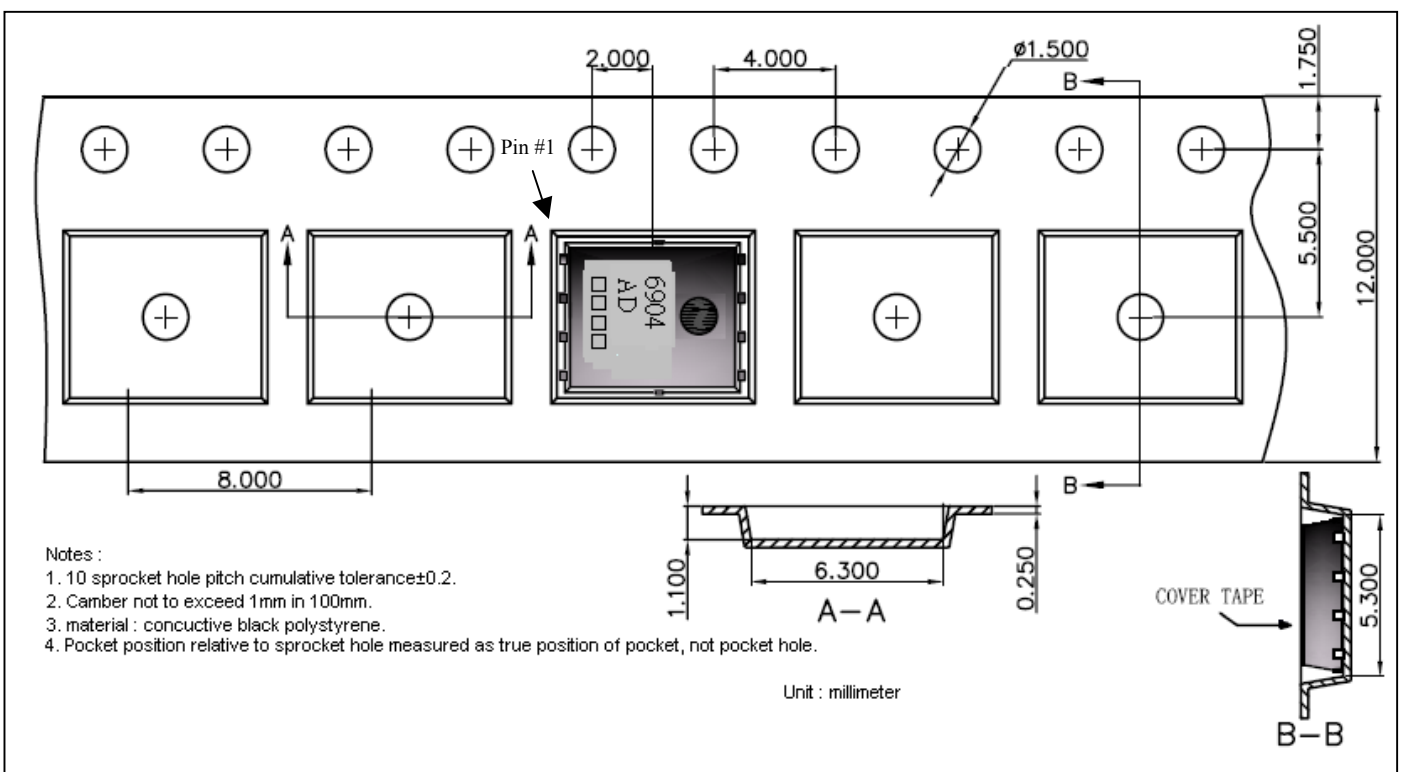
Transient Thermal Response Curves



Reel Dimension



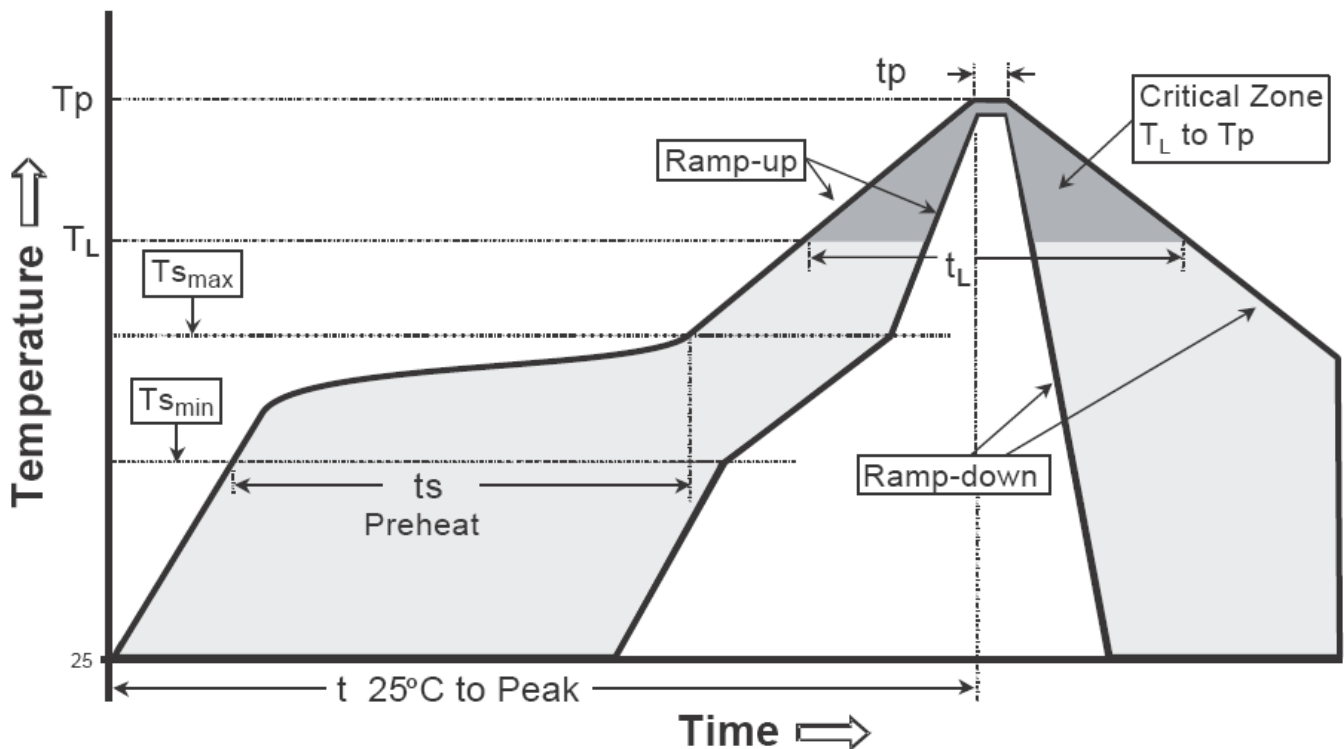
Carrier Tape Dimension



Recommended wave soldering condition

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

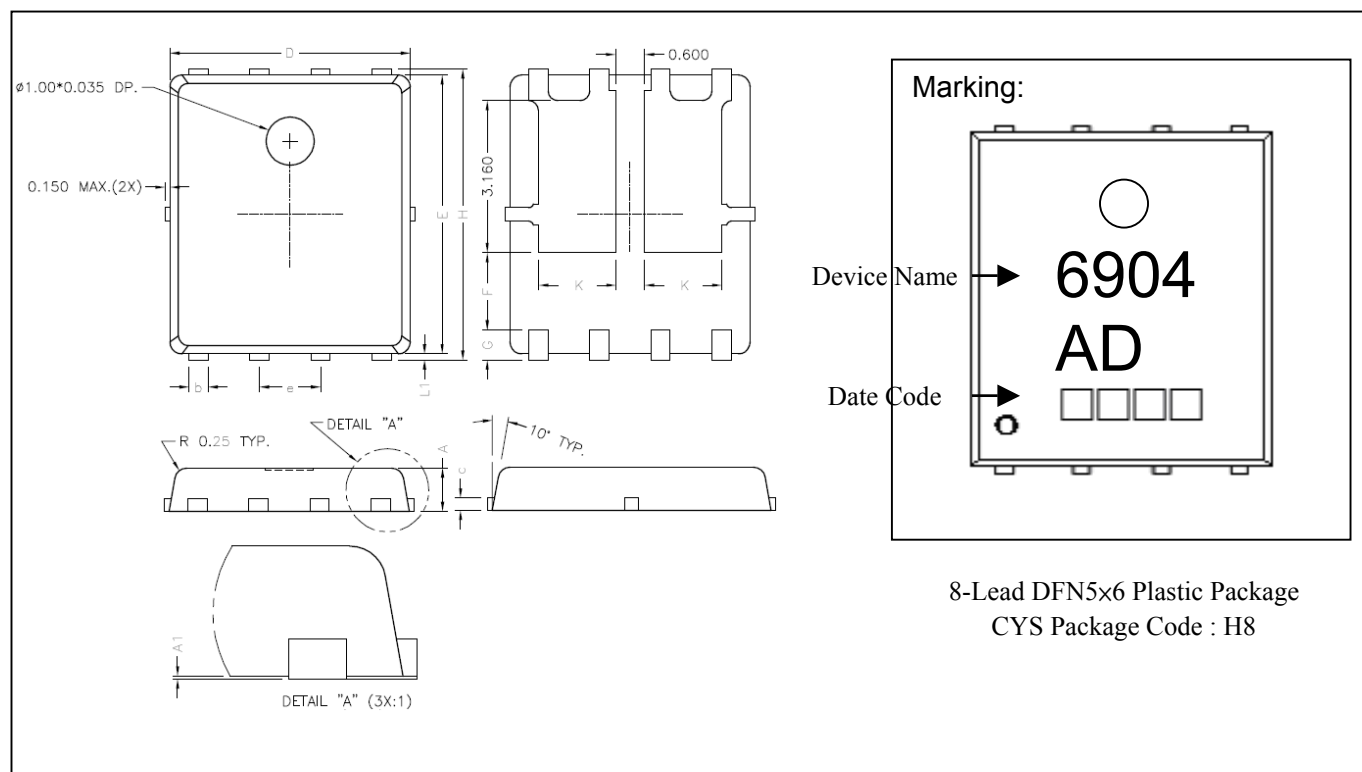
Recommended temperature profile for IR reflow



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (T _{smax} to T _p)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(T _s min)	100°C	150°C
-Temperature Max(T _s max)	150°C	200°C
-Time(t _s min to t _s max)	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (T _L)	183°C	217°C
- Time (t _L)	60-150 seconds	60-150 seconds
Peak Temperature(T _P)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

DFN5x6 Dimension



DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.80	1.00	0.031	0.039	E	5.70	5.90	0.224	0.232
A1	0.00	0.05	0.000	0.002	e	1.27	BSC	0.050	BSC
b	0.35	0.49	0.014	0.019	H	5.95	6.20	0.234	0.244
c	0.254	REF	0.010	REF	L1	0.10	0.18	0.004	0.007
D	4.90	5.10	0.193	0.201	G	0.60	REF	0.024	REF
F	1.60	REF	0.063	REF	K	1.60	REF	0.063	REF

Notes: 1. Controlling dimension: millimeters.

2. Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.

3. If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material:

- Lead: Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.

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